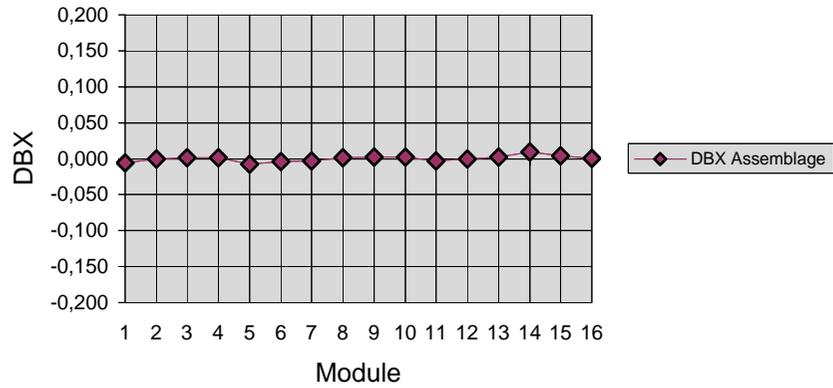
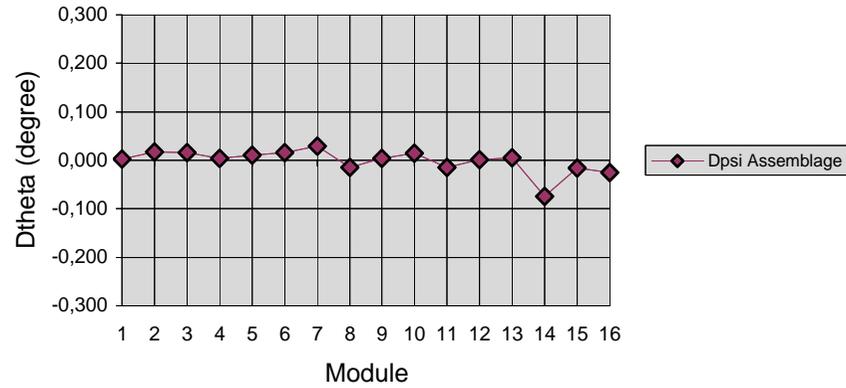


Graphiques

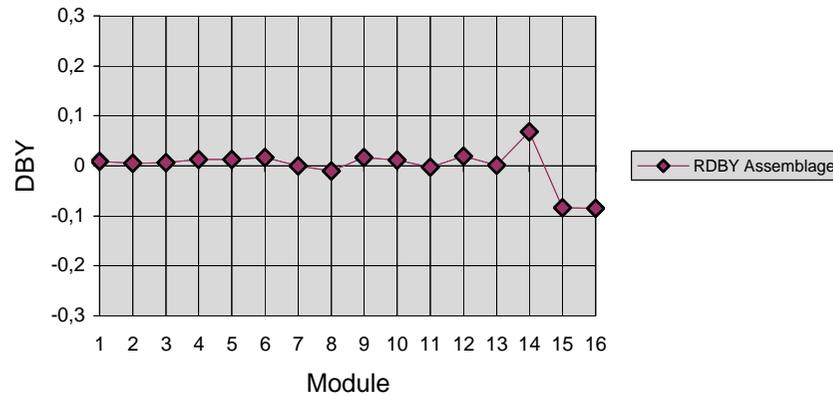
DBX (large edge)



Rotation in the wafer plane



DBY (small edge)



Ass. Order		20
Lad		3
Position	Run IV	XX
	Run V	1
	Run VI	1

Ladder not surveyed. Data taken from the ladder assembly operations.
 Module 15 shifted by 100 microns in Y
 Module 16 shifted by 130 microns in Y